


<b>Search Notes</b>  	<b>Application/Control No.</b>  10509074	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Sabiha Qazi	<b>Art Unit</b>  1612

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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STN DATABASE SEARCH, REGISTRY, AUTHOR SEARCH, CAPLUS, MARPAT, WPIX	1/26/10	STIC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Sabiha Qazi/ Primary Examiner.Art Unit 1612
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